

Search Notes

Application/Control No.

10/816,686

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
360	264.7	1/6/2008	MK
360	265.8	1/6/2008	MK
360	264.8	1/6/2008	MK
360	265.7	1/6/2008	MK
360	264.2	1/6/2008	MK
360	265	1/6/2008	MK
720	662	1/6/2008	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Search History Attached)	1/6/2008	MK